

# Resource Summary Report

Generated by [SPARC SAWG](#) on Jul 28, 2026

## Rensselaer Polytechnic Institute; New York; USA

RRID:SCR\_011492

Type: Tool

### Proper Citation

Rensselaer Polytechnic Institute; New York; USA (RRID:SCR\_011492)

### Resource Information

**URL:** <http://rpi.edu/>

**Proper Citation:** Rensselaer Polytechnic Institute; New York; USA (RRID:SCR\_011492)

**Abbreviations:** RPI

**Synonyms:** RPI

**Resource Type:** university, institution

**Resource Name:** Rensselaer Polytechnic Institute; New York; USA

**Resource ID:** SCR\_011492

**Record Creation Time:** 20220129T080305+0000

**Record Last Update:** 20260728T043353+0000

### Ratings and Alerts

No rating or validation information has been found for Rensselaer Polytechnic Institute; New York; USA.

No alerts have been found for Rensselaer Polytechnic Institute; New York; USA.

### Data and Source Information

**Source:** [SciCrunch Registry](#)

### Usage and Citation Metrics

We found 1 mentions in open access literature.

**Listed below are recent publications.** The full list is available at [SPARC SAWG](#) .

Ljosa V, et al. (2009) Introduction to the quantitative analysis of two-dimensional fluorescence microscopy images for cell-based screening. PLoS computational biology, 5(12), e1000603.